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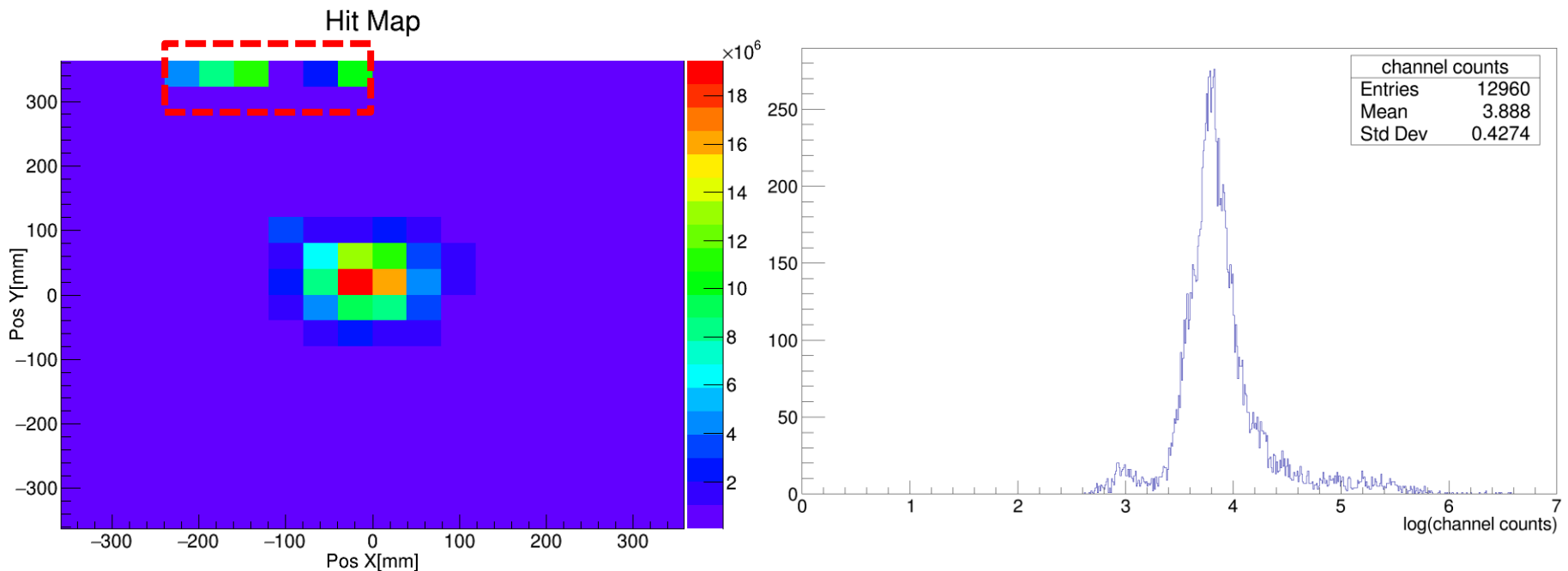
AHCAL MIP Calibration

Yukun Shi



- Use MIP data and Simulation information to do energy calibration
- Analyse HCAL and ECAL+HCAL muon data separately
 - HCAL: muon beam position fixed
 - ECAL+HCAL: muon beam position scanned
- First do fit on chip level
 - for channels with adequate counts, do fit on channel level
 - for channels without enough statistics, use chip results as itself parameter

- HCAL alone statistics
 - There are channels with light leakage
 - Most of the channel's statistics are around 10^4

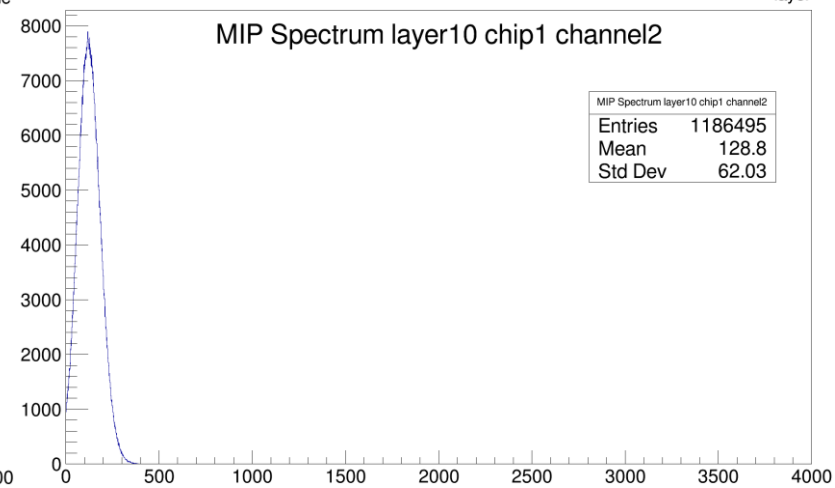
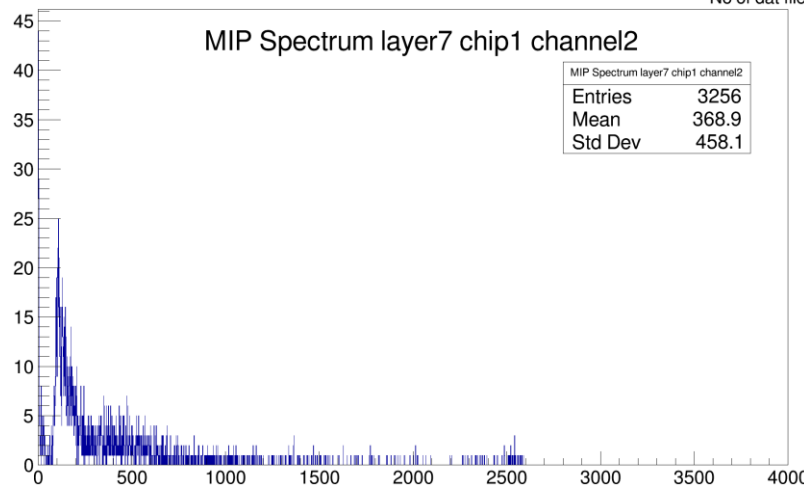
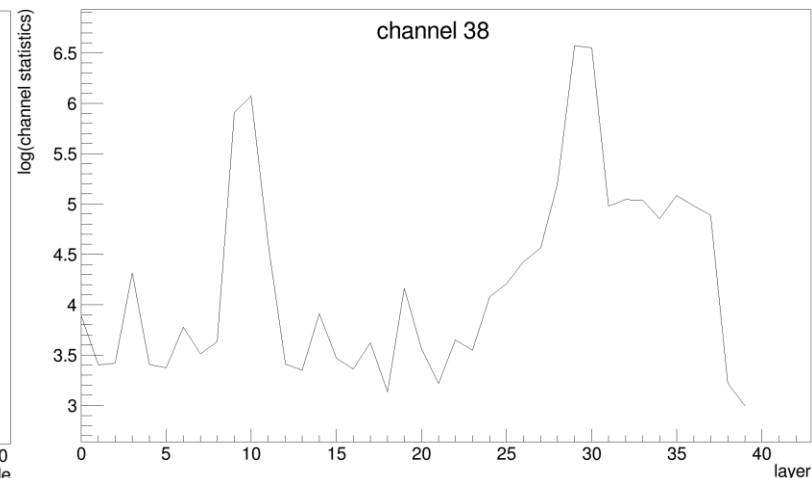
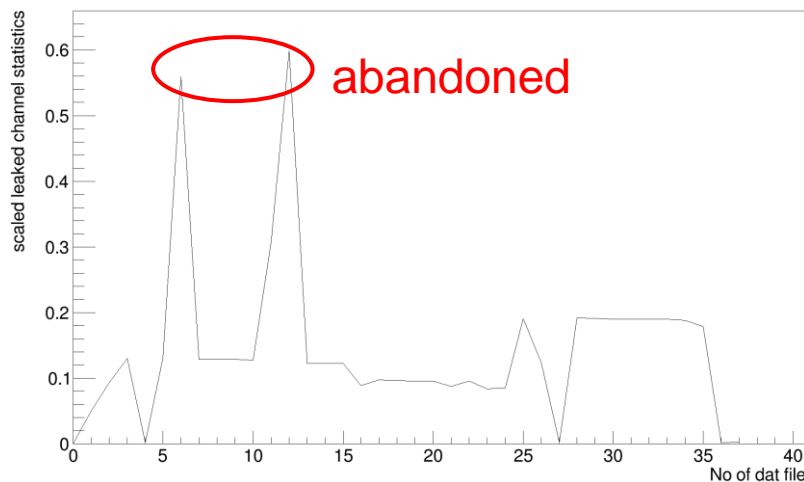


Statistics overview

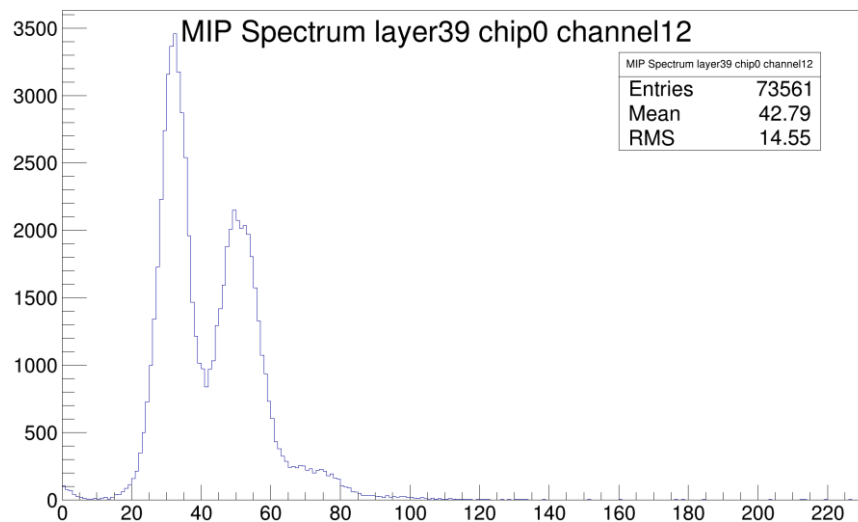


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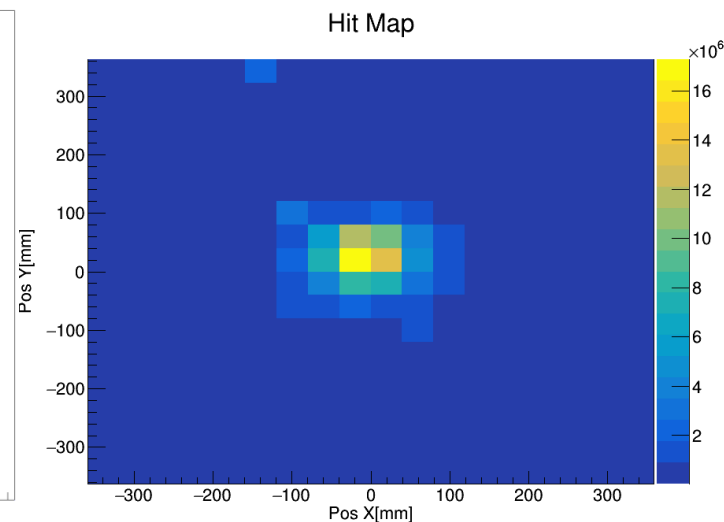
- HCAL alone leaked channels
 - No obvious time dependence
 - Abandon channels with $> 10^4$ counts



- Some abnormal NDL channels
- Selection criteria:
 - More than 10^4 counts & Mean value < 250
 - 90 channels(0.4%) are abandoned



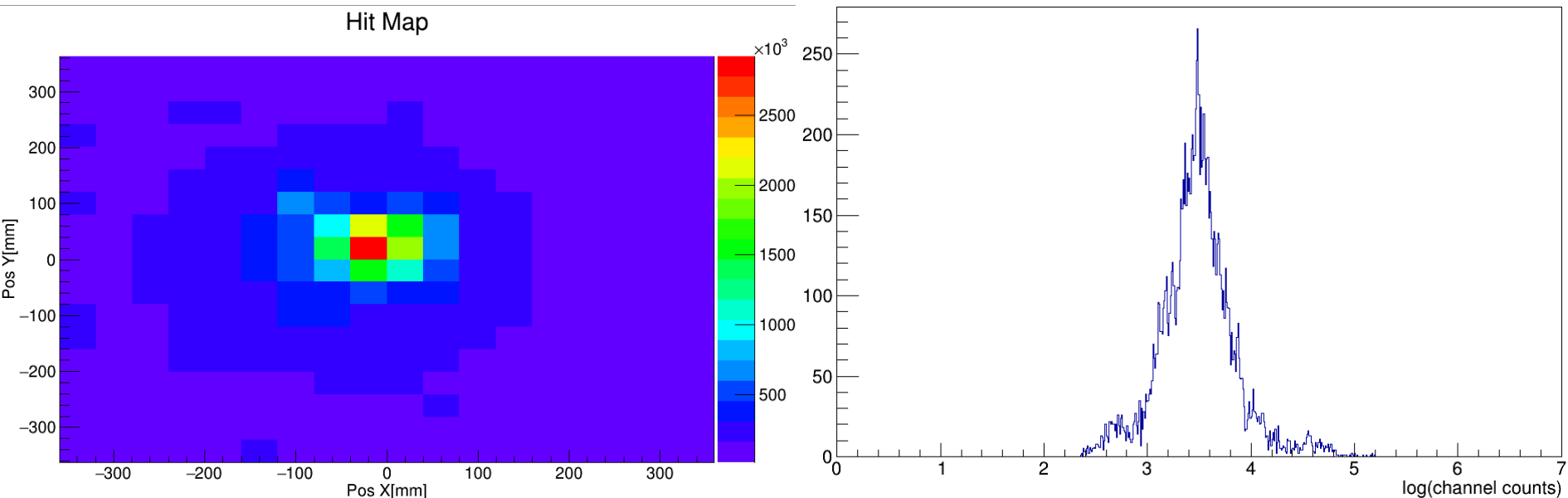
Abnormal NDL channel



Hit Map after selection

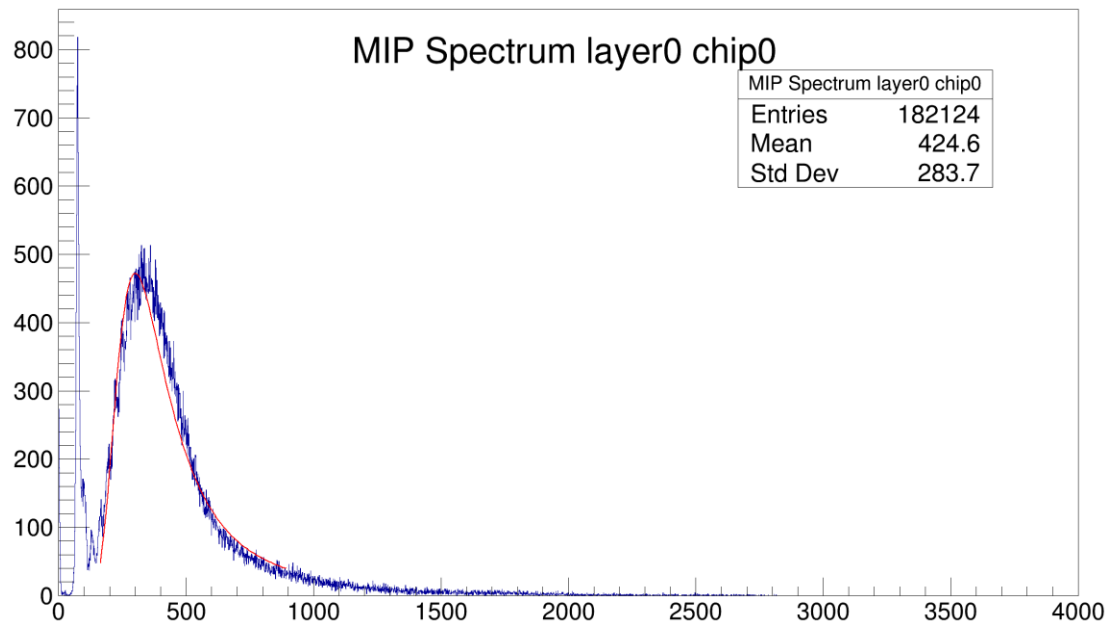


- Data in the ECAL+HCAL run
 - The light leakage has been fixed
 - NDL layers still have abnormal channels
 - The statistics is not enough for fitting at channel level





- Use HCAL alone Data
- The fitting and result check is going on





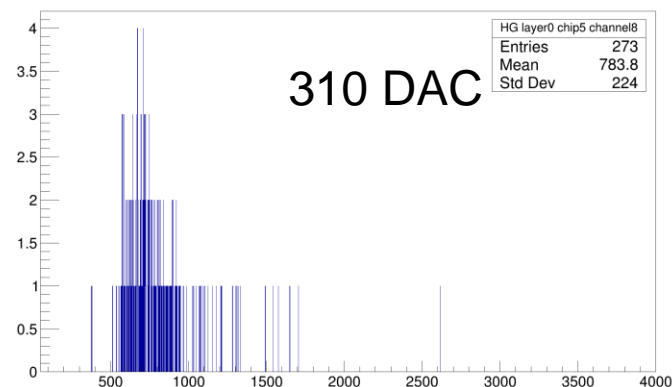
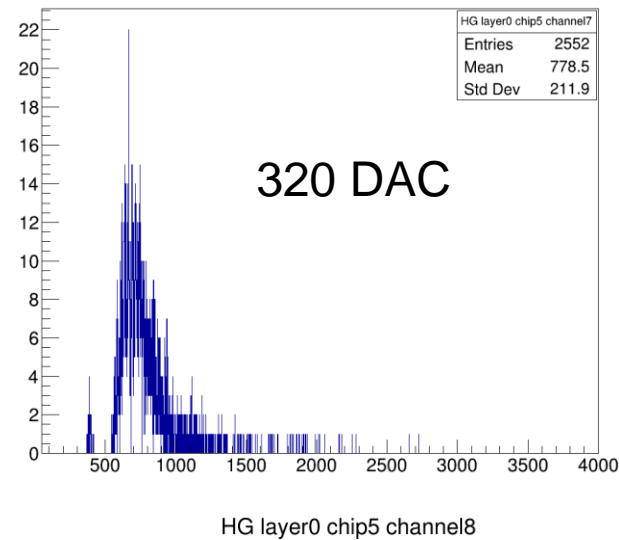
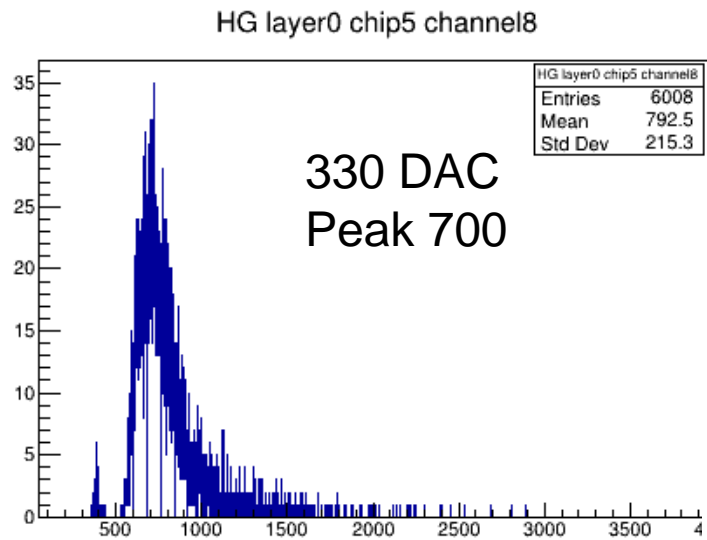
- The data selection will be iterated for better extraction of bad channels
- The fit at chip level is going on
- Fit at channel level will be done according to statistics and parameters from chip fitting results



- backup

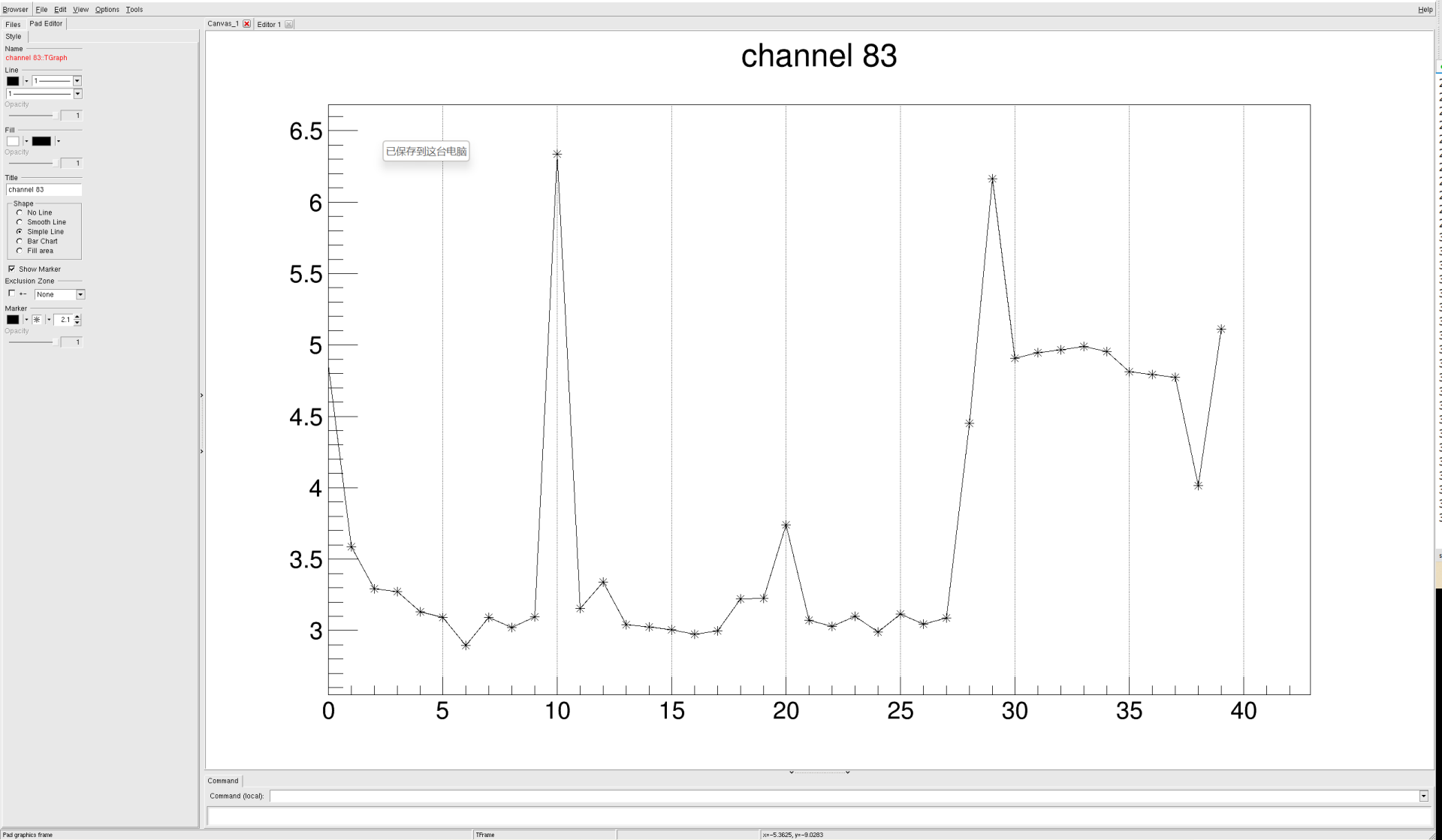


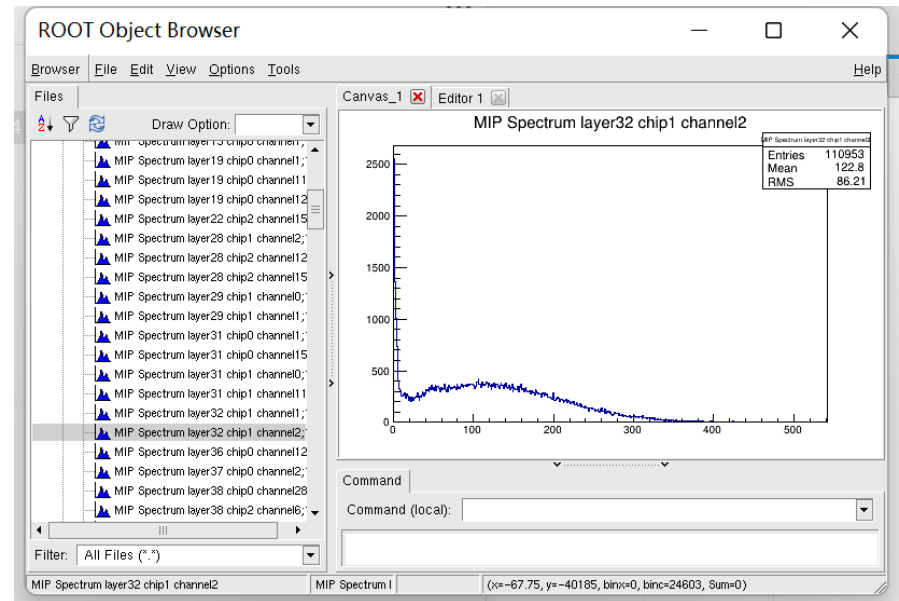
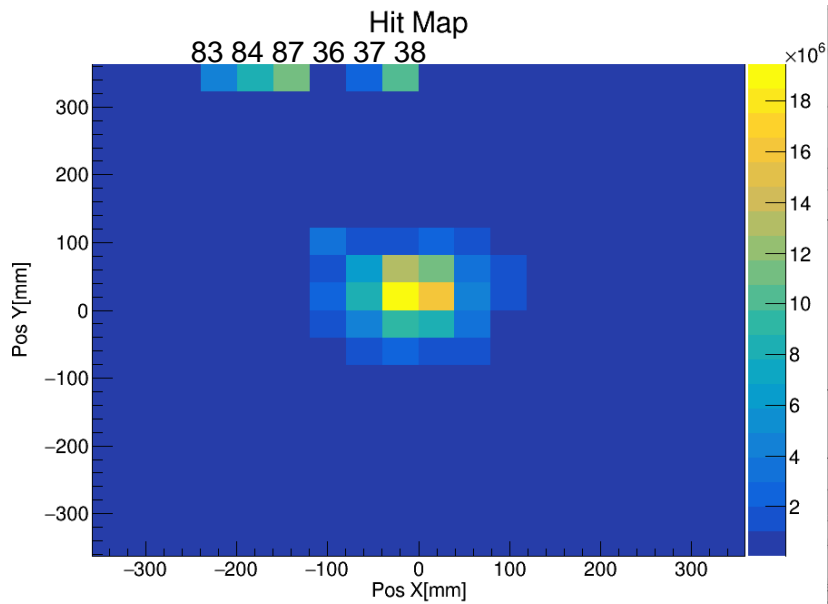
- Muon beam





ROOT Object Browser

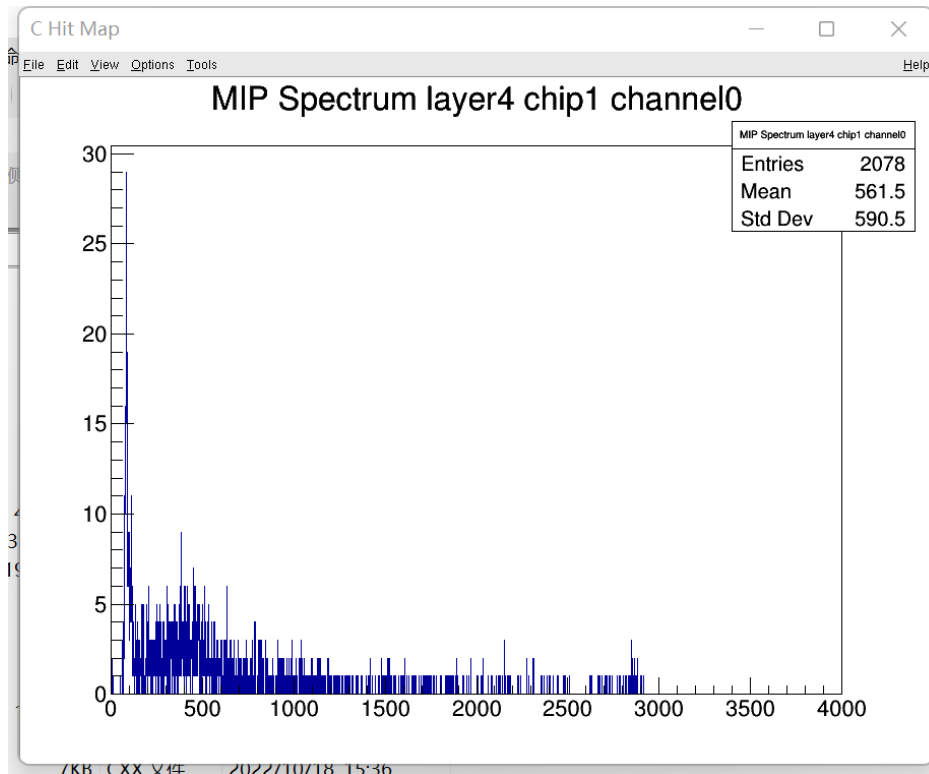




漏光通道

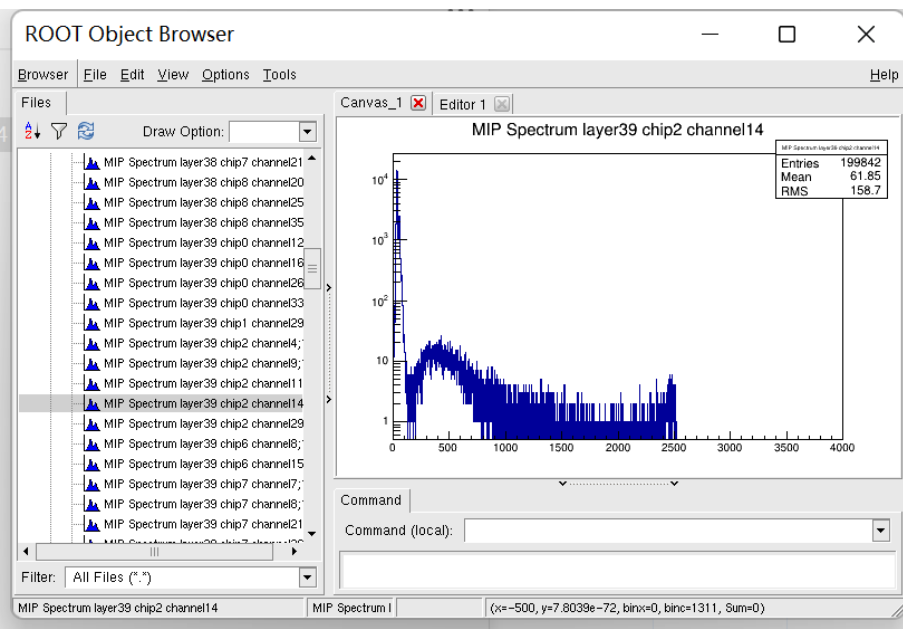
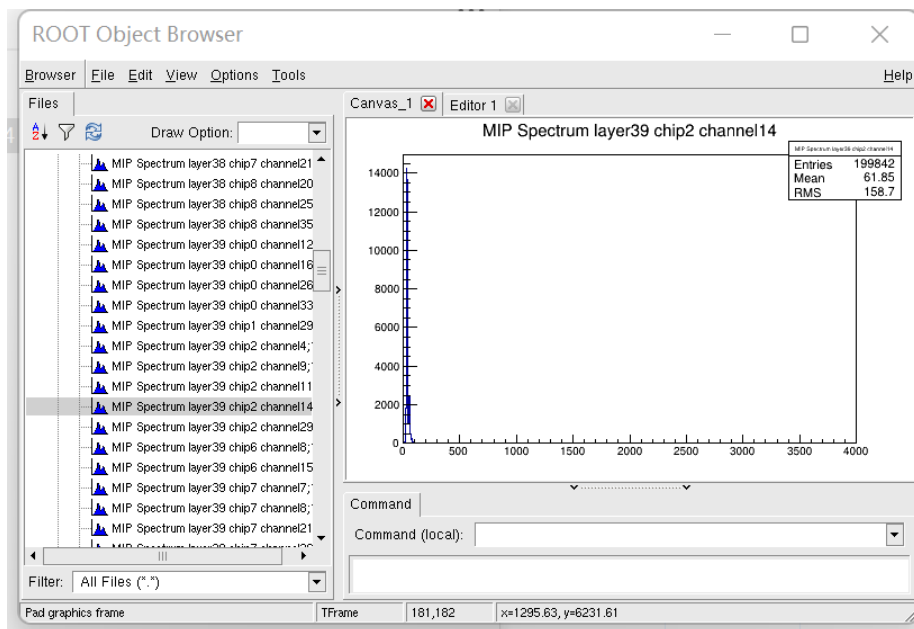


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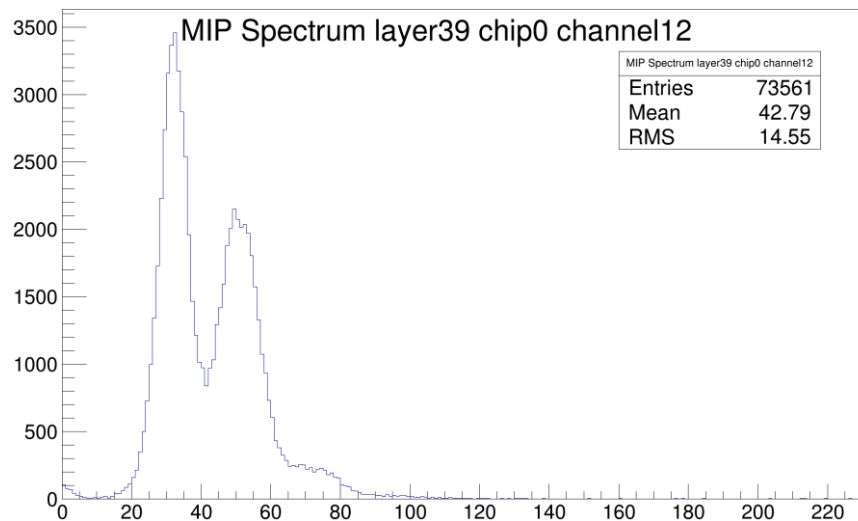


- 39 38 layer被误去除一部分





- Some abnormal NDL channels
- Selection criteria:
 - More than 10^4 counts & Mean value < 150
 - 57 channels(0.4%) are abandoned



Abnormal NDL channel